Form PTO-1	Form PTO-1449			U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1534			SERIAL NO. 09/881,408		
		LIST OF APA CIT	DD A PPLICAT	NT	APPLICANT Kie Y. Ahn, et al						
			2000 100	FILIN			GRO 2814		<del></del> _		
		OCI 2	No.	U.S. PATENT DOCUMENTS	June 13, 2001				شمد		
*Examiner Initial		Document Number	RADENHAL	Name		Class	Subclass	Filing I	Date opriate		
77	AA	6,387,761	08/2002	Shih	يري الم	The state of the s	ECH	[ר	짓		
72	АВ	4,432,035	02/1984	Hsieh et al		-	7	70 9	HOE HOE		
72	AC	6,436,777	08/2002	Ota			1	1057 CENTER 2:800			
72	AD	6,172,385	01/2001	Duncombe et al			*	THE TOP	夏它		
72	AE	5,566,045	10/1996	Summerfelt et al				15 25 E	-		
72	AF	5,554,564	09/1996	Nishioka et al				eg eg			
72	AG	5,605,858	02/1997	Nishioka et al			1				
R	АН	6,407,422	06/2002	Asano et al							
	AI										
	AJ										
	AK										
	AL										
				FOREIGN PATENT DOCUMENT	rs						
ļ		Document Number	Date	Country	Class	Subclass	Transla				
	AM		+					Yes	No		
	AN										
	AO					<b></b>	<u> </u>				
	AP AQ		+					-			
	_ ^~_	(	OTHER REFERENC	CES (including Author, Title, Date,	, Pertinent Pages, Etc.)						
	AR										
	AS										
	1							<del></del>			
	AT										
	,			<del></del>	<del></del>	<del></del>	<del></del>	<del> </del>			
EXAMINER				DATE CONSIDERE	ED						
*FYAMINER:	- Initial if	f	d ot citation		The shape						
considered. Ir	iclude cop	oy of this form with next c	communication to ap	n is in conformance with MPEP (	509; Draw line through	a citation ii	not in conto	rmance and no	)t		

Form PTO-1449			U.S. PAT	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET MI22-1534	SER 09/8	SERIAL NO. 09/881,408			
		LIST OF ART CIT			!	APPLICANT Kie Y. Ahn, et al	1		20,		
	-	OLAR	67		ļ	FILING DATE June 13, 2001		GRO 2814	OUP 4		
		OCT 2 9 20	002 10	U.S. PATENT DOCUME	ENTS						
*Examiner Initial		Dement Number	ato	Ne	lame		Class	Subclass	Filin If Apj	ng Date propriate	
77	AA	2002/0106536	08/2002	Lee et al							
九	AB	2001/0024868	09/2001	Nagel et al							
TL.	AC	2002/0006708	01/2002	Kang et al			the state of the s		<u> </u>		
	AD						2	ECH	<u> </u>		
	AE							CHMOLOG	80	RE	
	AF				_			_ <	$\omega$	CE CE	
	AG							CENI	2 ~	M	
	АН						- Art	- F	<b>1</b> 182	<del>U</del>	
	Al						100 mm	7800	4		
	AJ				_			· *			
	AK							<del>-</del>			
	AL							i			
				FOREIGN PATENT DOCUM	MENT	TS					
		Document Number	Date	Cour	ntry	ı	Class	Subclass		aslation	
	AM				_		+		Yes	No	
	AN				_						
,	AO	<del></del>				<del>_</del>	$\Box$				
-	AP			<del> </del>					<del>                                     </del>	<del> </del>	
	AQ	(	OTHER REFEREN	CES (including Author, Title, )	Date	Barring Pages, Etc	<del></del>				
			JIHLK NG	Es (including ranner,	Daic,	Pertinent rages, 2000,	1				
,	AR										
	AS								<u> </u>		
	AT _										
EXAMINER				DATE CONSID	DERE	∄D		_	_	_	
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											